

General Description

The WSP6077 is the highest performance trench P-ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications .

The WSP6077 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

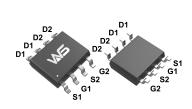
Product Summery

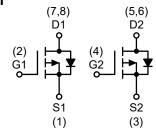
BV _{DSS}	R _{DSON}	I _D		
-60V	60mΩ	-8A		

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOP-8L Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-8.0	Α
I _D @T _C =100℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-4.5	Α
I _{DM}	Pulsed Drain Current ²	-30	А
P _D @T _C =25°C	Total Power Dissipation ³	1.5	W
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-Ambient ¹		70	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		35	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.02		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-5A	OV , I _D =-5A 60		80	0
R _{DS(ON)}	Static Dialii-Source On-Resistance	V _{GS} =-4.5V , I _D =-2A		64	100	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} . In =-250uA	-1.0	-1.5	-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID =-250UA		4.32		mV/℃
	Drain Source Leakage Current	V _{DS} =-52V , V _{GS} =0V , T _J =25℃			-1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-52V , V _{GS} =0V , T _J =55℃			-5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V_{DS} =-5V , I_D =-5A		15		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13	30	Ω
Q_g	Total Gate Charge (-4.5V)			10		
Q_{gs}	Gate-Source Charge	V_{DS} =-30V , V_{GS} =-4.5V , I_{D} =-5A		3.2		nC
Q _{gd}	Gate-Drain Charge			2.5		
T _{d(on)}	Turn-On Delay Time			19		
Tr	Rise Time	V _{DD} =-30V , V _{GS} =-10V ,		21		no
T _{d(off)}	Turn-Off Delay Time	$R_G=3.3\Omega I_D=-1A$		7.0		ns
T _f	Fall Time			55		
C _{iss}	Input Capacitance			1400		
C _{oss}	Output Capacitance	Capacitance V _{DS} =-30V , V _{GS} =0V , f=1MHz		95		pF
C _{rss}	Reverse Transfer Capacitance			70		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-8	Α
I _{SM}	Pulsed Source Current ^{2,4}	VG-VD-OV, Poice Current			-30	Α
V _{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =-1A , T_{J} =25 $^{\circ}$ C			-1.2	V

Note:

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

^{2.}The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.}The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

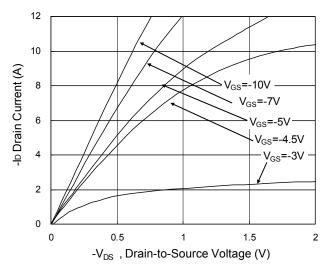
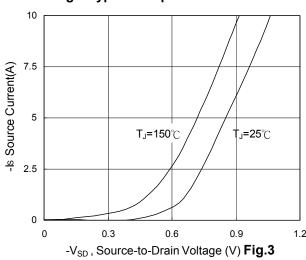


Fig.1 Typical Output Characteristics



Forward Characteristics of Reverse

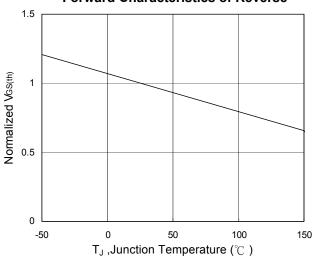


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

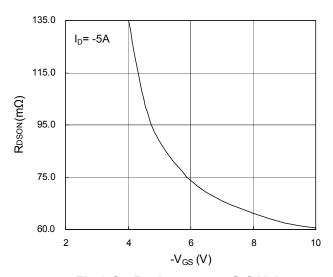


Fig.2 On-Resistance vs. G-S Voltage

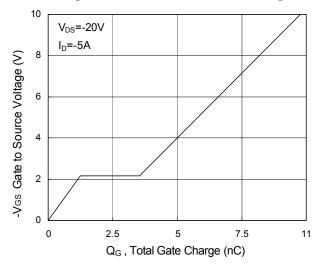


Fig.4 Gate-Charge Characteristics

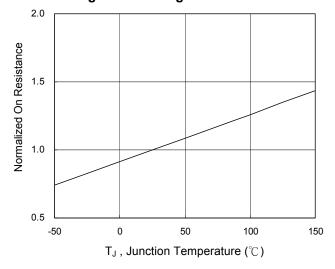
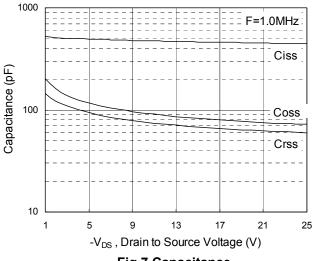


Fig.6 Normalized R_{DSON} vs. T_J





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Fig.7 Capacitance

Fig.8 Safe Operating Area

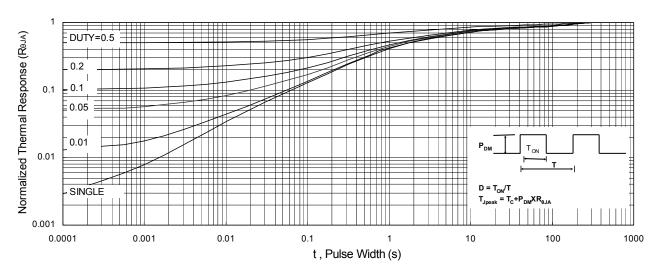
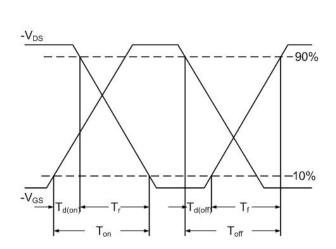


Fig.9 Normalized Maximum Transient Thermal Impedance



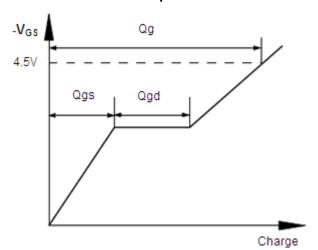
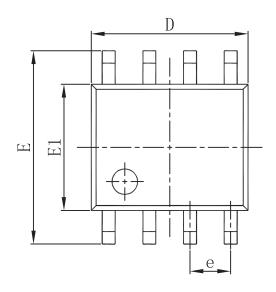


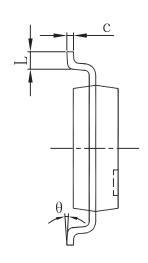
Fig.10 Switching Time Waveform

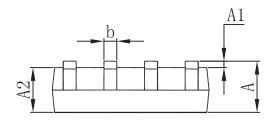
Fig.11 Gate Charge Waveform



Packaging information







Cross had	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1.750	0.053	0.069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0. 053	0.061	
b	0. 330	0.510	0. 013	0. 020	
c	0. 170	0. 250	0. 007	0.010	
D	4.800	5. 000	0. 189	0. 197	
e	1. 270 (BSC)		0.050 (BSC)		
Е	5. 800	6. 200	0. 228	0. 244	
E1	3. 800	4. 000	0. 150	0. 157	
L	0.400	1. 270	0. 016	0.050	
θ	0°	8°	0°	8°	



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